

**Search Notes**

Application/Control No.

10/714,759

Examiner

John T. Kwon

Applicant(s)/Patent under  
Reexamination

TAKAHASHI ET AL.

Art Unit

3747

**SEARCHED**

Class	Subclass	Date	Examiner
123	361	7/18/2005	JK
	376		
	377		
	399		
	400		

**INTERFERENCE SEARCHED**

Class	Subclass	Date	Examiner

**SEARCH NOTES  
(INCLUDING SEARCH STRATEGY)**

	DATE	EXMR
east	7/18/2005	JK